Searcn Notes				

Application No.	Applicant(s)	
09/898,043	HAYASHI ET AL.	
Examiner	Art Unit	
Johannes P Mondt	2826	

	SEARCHED				
Class	Subclass	Date	Examiner		
372	43-50	1/11/2005	JPM		
279	79-103	1/11/2005	JPM		
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
43-46	1/11/2005	JPM		
79, 103	1/11/2005	JPM		
	Subclass 43-46	Subclass Date 43-46 1/11/2005		

SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	')
	DATE	EXMR
East data bases and IEEE	1/11/2005	JPM
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